



# CERTIFICATE OF ACCREDITATION

**ANSI-ASQ National Accreditation Board**

500 Montgomery Street, Suite 625, Alexandria, VA 22314, 877-344-3044

This is to certify that

**Total Calibration Solutions, Inc.**  
**7722 Metric Drive**  
**Mentor, OH 44060**

has been assessed by ANAB  
and meets the requirements of international standard

**ISO/IEC 17025:2005**

and national standard

**ANSI/NCSL Z540-1-1994**

while demonstrating technical competence in the field of

**CALIBRATION**

Refer to the accompanying Scope of Accreditation for information regarding the types of calibrations to which this accreditation applies.

AC-1994

Certificate Number



ANAB Approval

Certificate Valid: 10/05/2016-10/13/2017  
Version No. 002      Issued: 10/05/2016



This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2005. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated January 2009).



**SCOPE OF ACCREDITATION TO  
ISO/IEC 17025:2005 AND ANSI/NCSL Z540-1-1994**

**Total Calibration Solutions, Inc.**

7722 Metric Drive  
Mentor, OH 44060  
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**CALIBRATION**

Valid to: October 13, 2017

Certificate Number: AC-1994

**Electromagnetic – DC/Low Frequency**

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*DC Voltage - Measure	Up to 100 mV (0.1 to 1) V (1 to 10) V (10 to 100) V (0.1 to 1) kV	1.4 $\mu$ V 8 $\mu$ V 77 $\mu$ V 1.1 mV 25 mV	HP 3458A Opt 002
	(1 to 200) kV	400 V	
*DC Voltage - Source	Up to 330 mV (0.33 to 3.3) V (3.3 to 33) V (33 to 330) V (0.330 to 1) kV	8.2 $\mu$ V 41 $\mu$ V 0.45 mV 6.5 mV 23 mV	Fluke 5522A
*DC Current - Measure	Up to 100 $\mu$ A (0.1 to 1) mA (1 to 10) mA (10 to 100) mA (0.1 to 1) A	7.4 nA 84 nA 0.7 $\mu$ A 9 $\mu$ A 0.11 mA	HP 3458A Opt 002
	(1 to 3) A (3 to 11) A (11 A to 20.5) A	11 mA 40 mA 73 mA	
*DC Current - Source	Up to 330 $\mu$ A (0.33 to 3.3) mA (3.3 to 33) mA (33 to 330) mA (0.33 to 1.1) A (1.1 to 3) A (3 to 11) A (11 to 20.5) A	0.11 $\mu$ A 0.56 $\mu$ A 9.1 $\mu$ A 87 $\mu$ A 0.29 mA 1.3 mA 7.1 mA 2.5 mA	Fluke 5522A

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*AC Voltage - Measure	Up to 10 mV (Up to 1) kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz (10 to 100) mV (Up to 1) kHz (1 to 20) kHz (20 to 100) kHz (100 to 300) kHz 100 mV to 1 V (Up to 1) kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 300) kHz (300 to 500) kHz (1 to 10) V (Up to 10) Hz (10 to 20) Hz (20 to 40) Hz 40 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (10 to 100) V (Up to 1) kHz (1 to 20) kHz (20 to 50) kHz (50 to 100) kHz (0.1 to 1) kV (Up to 20) kHz  (1 to 100) kV 60 Hz	4.7 $\mu$ V 9 $\mu$ V 90 $\mu$ V 0.72 mV  12 $\mu$ V 20 $\mu$ V 0.1 mV 0.39 mV  0.12 mV 0.2 mV 0.39 mV 0.97 mV 3.6 mV 12 mV  3.8 mV 1.4 mV 1.2 mV 1.2 mV 2 mV 2 mV 3.9 mV  9.6 mV 27 mV 28 mV 45 mV 0.15 V  0.36 V	HP 3458A Opt 002
*AC Voltage - Source	Up to 33 mV (10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz (33 to 330) mV (10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (33 to 3.3) V (10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (100 to 500) kHz	35 $\mu$ V 12 $\mu$ V 14 $\mu$ V 42 $\mu$ V 0.14 mV 0.34 mV  0.12 mV 60 $\mu$ V 65 $\mu$ V 0.13 mV 0.32 mV  11 mV 0.59 mV 0.73 mV 1.1 mV 2.9 mV 9.1 mV	Ross 200K, HP3458A Opt 002  Fluke 5522A

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*AC Voltage - Source	(3.3 to 33) V (10 to 45) Hz 45 Hz to 10 kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (33 to 330) V 45 Hz to 1 kHz (1 to 10) kHz (10 to 20) kHz (20 to 50) kHz (50 to 100) kHz (0.33 to 1.02) kV 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (1.02 to 50) kV 60 Hz	11 mV 5.9 mV 9.1 mV 13 mV 33 mV 69 mV 79 mV 94 mV 0.12 V 0.53 V 0.34 V 0.28 V 0.33 V 0.58 kV	Fluke 5522A  Hipot with Ross 200K, HP3458A Opt 002
*AC Current - Source	(29 to 330) $\mu$ A (10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz (0.33 to 3.3) mA (10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz (3.3 to 33) mA (10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz (33 to 330) mA (10 to 20) Hz (20 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (10 to 30) kHz (0.33 to 1.1) A (10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz (5 to 10) kHz (1.1 to 3) A (10 to 45) Hz 45 Hz to 1 kHz (1 to 5) kHz	0.82 $\mu$ A 0.64 $\mu$ A 0.55 $\mu$ A 1.2 $\mu$ A 3 $\mu$ A 6 $\mu$ A 7.6 $\mu$ A 4.8 $\mu$ A 3.9 $\mu$ A 8 $\mu$ A 19 $\mu$ A 38 $\mu$ A 66 $\mu$ A 34 $\mu$ A 17 $\mu$ A 32 $\mu$ A 74 $\mu$ A 0.14 mA 0.65 mA 0.34 mA 0.16 mA 0.41 mA 0.81 mA 1.6 mA 2.2 mA 0.71 mA 8.1 mA 35 mA 6.2 mA 2.2 mA 21 mA	Fluke 5522A

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment	
*AC Current - Source	(3 to 11) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz (11 to 20.5) A (45 to 100) Hz 100 Hz to 1 kHz (1 to 5) kHz	10 mA 15 mA 0.38 A  34 mA 41 mA 0.7 A	Fluke 5522A	
*AC Current - Measure	Up to 100 $\mu$ A 10 Hz to 5 kHz (0.1 to 1) mA 10 Hz to 5 kHz (1 to 10) mA 10 Hz to 5 kHz (10 to 100) mA 10 Hz to 5 kHz (0.1 to 1.1) A 10 Hz to 5 kHz	0.11 $\mu$ A  0.6 $\mu$ A  6.1 $\mu$ A  61 $\mu$ A  1.4 mA	HP 3458A Opt 002	
	(1.1 to 3) A (10 to 40) Hz 40 Hz to 1 kHz (1 to 5) kHz (3 to 11) A 45 Hz to 1 kHz (1 to 5) kHz (11 to 20.5) A 45 Hz to 1 kHz (1 to 5) kHz	13 mA 12 mA 0.2 A  43 mA 0.64 A  12 mA 0.2 A	HP 3458A Opt 002 with HP 34330A Shunt	
*Inductance - Source	100 $\mu$ H to 1 mH (1 to 10) mH (10 to 100) mH 100 mH to 1 H (1 to 10) H	17 $\mu$ H 0.14 $\mu$ H 0.69 mH 6.9 mH 69 mH	GR 1491D Decade Box, RLC GenRad 1689	
*Inductance - Measure	100 $\mu$ H to 1 mH (1 to 10) mH (10 to 100) mH 100 mH to 1 H (1 to 10) H	0.24 $\mu$ H 2.4 $\mu$ H 24 $\mu$ H 0.24 mH 2.3 mH	RLC GenRad 1689	
*Capacitance - Measure	Up to 1 nF (1 to 10) nF (10 to 100) nF 100 nF to 1 $\mu$ F (1 to 1.111) $\mu$ F	0.64 pF 2.4 pF 26 pF 0.41 nF 0.44 nF	RLC GenRad 1689	
*Capacitance - Source	20 Hz to 1 kHz 20 Hz to 1 kHz 20 Hz to 1 kHz 20 Hz to 1 kHz	100 pF to 1 nF (1 to 10) nF (10 to 100) nF 100 nF to 1 $\mu$ F	0.67 pF 6.3 pF 74 pF 0.62 nF	1423A Decade Box

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Capacitance - Source			
10 Hz to 10 kHz	(220 to 400) pF	15 pF	
10 Hz to 10 kHz	(0.4 to 1.1) nF	18 pF	
10 Hz to 3 kHz	(1.1 to 3.3) nF	23 pF	
10 Hz to 1 kHz	(3.3 to 11) nF	44 pF	
10 Hz to 1 kHz	(11 to 33) nF	0.17 nF	
10 Hz to 1 kHz	(33 to 110) nF	0.44 nF	
10 Hz to 1 kHz	(110 to 330) nF	0.92 nF	
(10 to 600) Hz	(0.33 to 1.1) $\mu$ F	4.1 nF	
(10 to 300) Hz	(1.1 to 3.3) $\mu$ F	12 nF	
(10 to 150) Hz	(3.3 to 11) $\mu$ F	44 nF	
(10 to 120) Hz	(11 to 33) $\mu$ F	0.18 $\mu$ F	
(10 to 80) Hz	(33 to 110) $\mu$ F	0.7 $\mu$ F	
(0 to 50) Hz	(110 to 330) $\mu$ F	2 $\mu$ F	
(0 to 20) Hz	(0.33 to 1.1) mF	12 $\mu$ F	
(0 to 6) Hz	(1.1 to 3.3) mF	20 $\mu$ F	
(0 to 2) Hz	(3.3 to 11) mF	89 $\mu$ F	
(0 to 0.6) Hz	(11 to 33) mF	0.31 mF	
(0 to 0.2) Hz	(33 to 110) mF	1.4 mF	
			Fluke 5522A
	100 $\Omega$ in 10 $\Omega$ Steps	3.1 m $\Omega$	
	1 k $\Omega$ in 100 $\Omega$ Steps	27 m $\Omega$	
	10 k $\Omega$ in 1 k $\Omega$ Steps	0.26 $\Omega$	
	100 k $\Omega$ in 10 k $\Omega$ Steps	2.6 $\Omega$	
	1.1 M $\Omega$ in 100 k $\Omega$ Steps	29 $\Omega$	ESI RS925A Resistance Decade Box
*DC Resistance - Source	Up to 10 $\Omega$	1.6 m $\Omega$	
	(1.1 to 3.3) M $\Omega$	0.29 k $\Omega$	
	(3.3 to 11) M $\Omega$	0.35 k $\Omega$	
	(11 to 33) M $\Omega$	12 k $\Omega$	
	(33 to 110) M $\Omega$	66 k $\Omega$	
	(110 to 330) M $\Omega$	1.2 M $\Omega$	
	(0.33 to 1.1) G $\Omega$	18 M $\Omega$	Fluke 5522A
*DC Resistance - Measure	Up to 10 $\Omega$	0.31 m $\Omega$	
	(10 to 100) $\Omega$	2.7 m $\Omega$	
	(0.1 to 1) k $\Omega$	18 m $\Omega$	
	(1 to 10) k $\Omega$	0.18 $\Omega$	
	(10 to 100) k $\Omega$	1.8 $\Omega$	
	(0.1 to 1) M $\Omega$	25 $\Omega$	
	(1 to 10) M $\Omega$	0.78 k $\Omega$	
	(10 to 100) M $\Omega$	68 k $\Omega$	HP 3458A Opt 002

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
* Oscilloscopes Amplitude - DC 50 $\Omega$ 1 M $\Omega$	(-6.6 to 6.6) V (-130 to 130) V	20 mV 15 mV	
Amplitude - Square Wave 50 $\Omega$ 1 M $\Omega$ Frequency	1 mV to 6.6 V (p-p) 1 mV to 130 V (p-p) 10 Hz to 10 kHz	13 mV 18 mV 29 Hz	
Time Markers into 50 $\Omega$ Load	1 ns to 20 ms 50 ms to 5 s	8.2 $\mu$ s 29 ms	
Leveled Sine Wave (5 mV to 5.5 V) p-p  (5 mV to 3.5 V) p-p	50 kHz reference 50 kHz to 100 MHz (100 to 300) MHz (300 to 600) MHz 600 MHz to 1.1 GHz	0.13 V 0.1 V 0.14 V 0.26 V 0.2 V	
Edge Characteristics into 50 $\Omega$ Load Rise Time Amplitude Frequency	Up to 300 ps 4.5 mV to 2.75 V 1 kHz to 10 MHz	+0/-120 ps 63 mV 29 Hz	Fluke 5522A/SC1100
Wave Generator Square, Sine, Triangle Amplitude Into 50 $\Omega$ Load Into 1 M $\Omega$ Load Frequency	(1.8 mV to 55 V) p-p (1.8 mV to 55 V) p-p 10 Hz to 100 kHz	88 mV 2 V 0.29 Hz	
Pulse - Source 50 $\Omega$ Load Period Width	22 ms to 200 ns 45.5 Hz to 5 MHz (4 to 500) ns	6.1 ns 1.2 ns	
Input Resistance Measurement	(40 to 60) $\Omega$	56 m $\Omega$	
Oscilloscope Capacitance Measurement	(0.5 to 1.5) M $\Omega$  (5 to 50) pF	2.5 k $\Omega$  1.3 pF	
* Electrical Simulation of Thermocouple Indicators	Type B (600 to 800) °C (800 to 1 000) °C (1 000 to 1 550) °C (1 550 to 1 820) °C	0.53 °C 0.42 °C 0.37 °C 0.4 °C	Fluke 5522A
	Type C (0 to 150) °C (150 to 650) °C (650 to 1 000) °C (1 000 to 1 800) °C (1 800 to 2 316) °C	0.35 °C 0.31 °C 0.38 °C 0.59 °C 0.98 °C	

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Electrical Simulation of Thermocouple Indicators	Type E (-250 to -100) °C (-100 to -25) °C (-25 to 350) °C (350 to 650) °C (650 to 1 000) °C  Type J (-210 to -100) °C (-100 to -30) °C (-30 to 150) °C (150 to 760) °C (760 to 1 200) °C  Type K (-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 1 000) °C (1 000 to 1 372) °C  Type L (-200 to -100) °C (-100 to 800) °C (800 to 900) °C  Type N (-200 to -100) °C (-100 to -25) °C (-25 to 120) °C (120 to 410) °C (410 to 1 300) °C  Type R (0 to 250) °C (250 to 400) °C (400 to 1 000) °C (1 000 to 1 767) °C  Type S (0 to 250) °C (250 to 1 000) °C (1 000 to 1 400) °C (1 400 to 1 767) °C  Type T (-250 to -150) °C (-150 to 0) °C (0 to 120) °C (120 to 400) °C  Type U (-200 to 0) °C (0 to 600) °C	0.58 °C 0.19 °C 0.17 °C 0.19 °C 0.25 °C  0.33 °C 0.20 °C 0.17 °C 0.21 °C 0.27 °C  0.39 °C 0.22 °C 0.19 °C 0.31 °C 0.48 °C  0.44 °C 0.32 °C 0.22 °C  0.47 °C 0.26 °C 0.23 °C 0.22 °C 0.33 °C  0.67 °C 0.42 °C 0.4 °C 0.48 °C  0.56 °C 0.43 °C 0.44 °C 0.54 °C  0.74 °C 0.3 °C 0.19 °C 0.17 °C  0.66 °C 0.33 °C	Fluke 5522A
*Electrical Simulation of RTD Indicators	Pt 385, 100 Ω (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 300) °C (300 to 400) °C (400 to 630) °C (630 to 800) °C	0.06 °C 0.06 °C 0.09 °C 0.11 °C 0.12 °C 0.14 °C 0.27 °C	Fluke 5522A

## Electromagnetic – DC/Low Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Electrical Simulation of RTD Indicators	Pt 385, 200 $\Omega$ (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C  Pt 385, 500 $\Omega$ (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C  Pt 385, 1 000 $\Omega$ (-200 to -80) °C (-80 to 0) °C (0 to 100) °C (100 to 260) °C (260 to 300) °C (300 to 400) °C (400 to 600) °C (600 to 630) °C	0.05 °C 0.05 °C 0.05 °C 0.06 °C 0.15 °C 0.18 °C 0.18 °C 0.19 °C  0.05 °C 0.06 °C 0.06 °C 0.07 °C 0.09 °C 0.09 °C 0.11 °C 0.13 °C  0.04 °C 0.04 °C 0.08 °C 0.06 °C 0.07 °C 0.08 °C 0.08 °C 0.27 °C	Fluke 5522A
*Phase Angle – Source (65 to 500) Hz	(0 to 360) °	0.29 °	Fluke 5522A

## Electromagnetic – RF/Microwave

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*RF Power - Measure Up to 18 GHz	(-30 to -20) dBm	0.79 dBm	HP 8902A with HP8481 Power Sensor
*Amplitude Modulation - Measure 150 kHz to 10 MHz Rate: 50 Hz to 10 kHz Rate: 20 Hz to 10 kHz Rate: 50 Hz to 50 kHz  10 MHz to 1.3 GHz Rate: 20 Hz to 100 kHz	(5 to 99) %Depth Up to 99%Depth (5 to 99) %Depth  Up to 99 %Depth	2.4 %Depth 3.6 %Depth 1.3 %Depth  3.6 %Depth	HP 8902A
*Frequency Modulation - Measure 250 kHz to 10 MHz  10 MHz to 1.3 GHz	Rate: 20 Hz to 10 kHz ≤ 40 kHz peak Rate: 50 Hz to 100 kHz ≤ 400 kHz peak Rate: 20 Hz to 200 kHz ≤ 400 kHz peak	0.25 kHz 1.3 kHz 5.9 kHz	HP 8902A
*Phase Modulation - Measure 150 kHz to 10 MHz 10 MHz to 1.3 GHz	Rate: 200 Hz to 10 kHz Rate: 200 Hz to 20 kHz	0.2 rad 14 rad	HP 8902A

## Time and Frequency

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Frequency - Source	1 MHz to 3 GHz	29 parts in $10^{10}$	HP E4422B Signal Generator locked to EFRATOM Rubidium Frequency Standard
*Frequency - Measure	(0.1 to 3) GHz	29 parts in $10^{10}$	HP 53132A

## Thermodynamic

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Humidity	(10 to 95) %RH	0.71 %	Thunder Scientific 2500
*Temperature	(-196 to -20) °C (-20 to 150) °C (150 to 660) °C	0.021 °C 0.017 °C 0.062 °C	Liquid Nitrogen Temperature Bath Fluke 5681 PRT HP 3458A Opt 002

## Dimensional

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Calipers	Up to 40 in	(13L+140) $\mu$ in	Gage Blocks/ Surface Plate
*Micrometers	Up to 6 in (6 to 20) in	(9.2L + 21) $\mu$ in (16L + 180) $\mu$ in	
*Indicators, Dial, Test	Up to 4 in	(30L - 5.5) $\mu$ in	
*Height Gages	Up to 24 in	200 $\mu$ in	
* Optical Comparators	Up to 12 in	200 $\mu$ in	Gage Line Glass Standard
X and Y Axis Linearity			Gage Line Glass Standard
Angle	(0 to 90) °	0.11 °	and Angle Blocks

## Mechanical

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
*Pressure Gages & Transducers	(-1 to 1) psig (1 to 5) psig (5 to 190) psig (190 to 200) psig (200 to 20 000) psig	0.00024 psig 0.03 % of reading 0.016 % of reading 0.03 % of reading 0.012 % of reading	Ruska 7250LP Fluke PM600-A1.4M with 6270A Pressure Controller Druck DPI-145 Fluke P3116 Deadweight Tester
*Vacuum	(Up to 15) psia	0.03 % of reading	Druck DPI 145
*Mass Flow	(0.5 to 50) SCCM (50 to 5 000) SCCM (5 to 100) SLPM (100 to 5 000) SLPM	0.31 % of reading 0.16 % of reading 0.18 % of reading 0.28 % of reading	ML-800-3/ML-800-24ML- 800-75 Fluke 5E2-S Molbloc Fluke 2E3-S Molbloc Fluke 1E4-S Molbloc Fluke Molbox and Mass Flow Terminal
* Liquid Flow	(1 to 60) GPM	0.45 % of reading	Cox Liquid Flow Standard
*Torque Source	(2.5 to 500) lbf-in (41.6 to 800) lbf-ft	0.1 % of reading	Torque Arms, F Class Weights
*Torque Tools	(0.12 to 1.25) lbf-in (1.25 to 5) lbf-in (5 to 50) lbf-in (50 to 180) lbf-in (15 to 75) lbf-ft (75 to 700) lbf-ft	0.0075 lbf-in 0.5 lbf-in 0.33 lbf-in 1.2 lbf-in 0.25 lbf-ft 2.3 lbf-ft	Mountz BMX20Z Mountz BMX80Z Mountz BMX50I Mountz BMX250I Norbar 50593 Norbar 50597
* Force - Compression & Tension	(Up to 500) lbf	0.1 lbf	Class F Weights
* Force - Compression & Tension	(500 to 1 000) lbf (1 000 to 2 500) lbf (2 500 to 5 000) lbf (5 000 to 7 500) lbf (7 500 to 10 000) lbf (10 000 to 25 000) lbf (25 000 to 50 000) lbf	0.63 lbf 2.1 lbf 2.7 lbf 5.3 lbf 6.3 lbf 22 lbf 31 lbf	Load Cells

## Mechanical

Parameter/ Equipment	Range	Calibration and Measurement Capability [Expressed as Uncertainty ( $\pm$ )]	Reference Standard or Equipment
* Laboratory and Precision Balances			
0.001 mg resolution	Up to 20 g	14 $\mu$ g	
0.01 mg resolution	Up to 40 g	30 $\mu$ g	
0.01 mg resolution	Up to 60 g	39 $\mu$ g	
0.01 mg resolution	Up to 80g	45 $\mu$ g	
0.01 mg resolution	Up to 100 g	71 $\mu$ g	
0.01 mg resolution	Up to 200 g	77 $\mu$ g	
0.1 mg resolution	Up to 500 g	0.89 mg	
1 mg resolution	Up to 1 kg	2.6 mg	
1 mg resolution	Up to 2 kg	2.8 mg	
mg resolution	Up to 4 kg	4.3 mg	
1 mg resolution	Up to 5 kg	14 mg	
1 mg resolution	Up to 10 kg	24 mg	
1 mg resolution	Up to 15 kg	99 mg	
0.1 g resolution	Up to 20 kg	0.11g	
* Bench Scales			Class 1 Weights
0.001 lb resolution	Up to 20 lb	0.0011 lb	
0.01 lb resolution	Up to 50 lb	0.0074 lb	
0.01 lb resolution	Up to 100 lb	0.0096 lb	
0.1 lb resolution	Up to 600 lb	0.077 lb	
0.1 lb resolution	Up to 1 000 lb	0.12 lb	
0.1 lb resolution	Up to 2 000 lb	0.17 lb	
0.5 lb resolution	Up to 3 000 lb	0.37 lb	
0.5 lb resolution	Up to 40 00 lb	0.48 lb	
* Pipettes	(0.5 to 2) $\mu$ L (2 to 10) $\mu$ L (10 to 20) $\mu$ L (20 to 100) $\mu$ L (100 to 200) $\mu$ L (200 to 500) $\mu$ L (500 to 1 000) $\mu$ L (1 000 to 5 100) $\mu$ L	0.076 $\mu$ L 0.078 $\mu$ L 0.08 $\mu$ L 0.094 $\mu$ L 0.16 $\mu$ L 0.4 $\mu$ L 0.51 $\mu$ L 2.5 $\mu$ L	Micro-Balance

**Notes:**

1. Calibration and Measurement Capabilities (Expanded Uncertainties) are based on approximately a 95% confidence interval, using a coverage of k=2.
2. This laboratory offers in-laboratory calibration service as well as on-site calibrations at customer-designated locations. Since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope. Parameters identified by an asterisk (\*) are accredited for on-site calibration.
3. The use of L in CMC represents length in inches.
4. This scope is formatted as part of a single document including the Certificate of Accreditation No. AC-1994



Vice President